

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10579567	NAKAGAWA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Christopher Verdier	3745

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
384	568, 558, 567, 563, 569, 450	1/18/10	CV
416	174	1/18/10	CV
415	229-231	1/18/10	CV

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
consulted - Hannon (384)	1/13/10	CV
Inventor name search (EAST - USPAT, USPGPUB) - see attached search history	1/18/10	CV
Inventor name search (PALM) - see attached search history	1/18/10	CV

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

	/Christopher Verdier/ Primary Examiner.Art Unit 3745
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